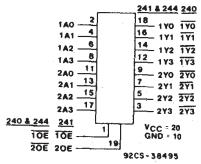
Advance Information



Data sheet acquired from Harris Semiconductor SCHS287B – Revised January 2004



Octal Buffer/Line Drivers, 3-State

CD54/74AC/ACT240 - Inverting CD54/74AC/ACT241 - Non-Inverting CD54/74AC/ACT244 - Non-Inverting

Type Features:

- Buffered inputs
- Typical propagation delay: 3.6 ns @ Vcc = 5 V, T_A = 25° C, C_L = 50 pF

FUNCTIONAL DIAGRAM & TERMINAL ASSIGNMENT

The RCA CD54/74AC240, CD54/74AC241, and CD54/74AC244 and the CD54/74ACT240, CD54/74ACT241, and CD54/74ACT244 3-state octal buffer/line drivers use the RCA ADVANCED CMOS technology. The CD54/74AC/ACT240 and CD54/74AC/ACT244 have active-LOW output enables (10E, 20E). The CD54/74AC/ACT241 has one active-LOW (10E) and one active-HIGH (20E) output enable.

The CD74AC240 and CD74ACT240 are supplied in 20-lead dual-in-line plastic packages (E suffix) and 20-lead small-outline packages (M and M96 suffixes). The CD74AC241 is supplied in 20-lead dual-in-line plastic packages (E suffix) and the CD74ACT241 is supplied in 20-lead dual-in-line plastic packages (E suffix) and 20-lead small-outline packages (M96 suffix). The CD74AC244 and CD74ACT244 are supplied in 20-lead dual-in-line plastic packages (E suffix), 20-lead small-outline packages (M and M96 suffixes), and 20-lead shrink small-outline packages (SM96 suffix). These package types are operable over the following temperature ranges: Commerical (0 to 70°C); Industrial (–40 to +85°C); and Extended Industrial/Military (–55 to + 125°C).

The CD54AC240 and CD54AC244 and the CD54ACT240, CD54ACT241, and CD54ACT244 are supplied in 20-lead hermetic dual-in-line ceramic packages (F3A suffix) and are operable over the -55 to +125°C temperature range.

Family Features:

- Exceeds 2-kV ESD Protection MIL-STD-883, Method 3015
- SCR-Latch-up-resistant CMOS process and circuit design
- Speed of bipolar FAST*/AS/S with significantly reduced power consumption
- Balanced propagation delays
- AC types feature 1.5-V to 5.5-V operation and balanced noise immunity at 30% of the supply
- ± 24-mA output drive current
 - Fanout to 15 FAST* ICs
 - Drives 50-ohm transmission lines

TRUTH TABLES

	INPUTS			
10E, 20E	10E, 20E A			
L	L	Н		
L	Н	L		
Н	X	Z		

(AC/ACT240)

INPU	ITS	OUTPUT
10E, 20E	Α	Y
L	, L	L
L	Н	Н
н	X	Z

(AC/ACT244)

INP	UTS	OUTPUT	PUT INPUTS		OUTPUT
10E	1A	1Y	20E	2A	2Y
L	L	L	L	Х	Z
L	н	H	н	L	L
н	х	Z	Н	н	н

(AC/ACT241)

H = HIGH Voltage Level L = LOW Voltage Level X = Immaterial

Z = HIGH Impedance

This data sheet is applicable to the CD54/74AC240, CD54ACT240, and CD54/74ACT241. The CD54/74AC241 were not acquired from Harris Semiconductor. See SCHS244 for information on the CD74ACT240, CD74AC244, and CD74ACT244. Copyright © 2004, Texas Instruments Incorporated

^{*}FAST is a Registered Trademark of Fairchild Semiconductor Corp.

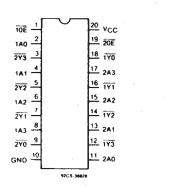
MAXIMUM RATINGS, Absolute-Maximum Values:
DC SUPPLY-VOLTAGE (V _{CC})0.5 to 6 V
DC INPUT DIODE CURRENT, I_{iK} (for $V_1 < -0.5 \text{ V}$ or $V_1 > V_{CC} + 0.5 \text{ V}$)
DC OUTPUT DIODE CURRENT, l_{OK} (for $V_0 < -0.5$ V or $V_0 > V_{CC} + 0.5$ V)
DC OUTPUT SOURCE OR SINK CURRENT per Output Pin, Io (for Vo > -0.5 V or Vo < Vcc + 0.5 V)
DC V _{∞} or GROUND CURRENT (I _{∞} or I _{GNO})
POWER DISSIPATION PER PACKAGE (PD):
For T _A = -40 to +85°C (Package Type E)
For T _A = -40 to +70°C (Package Type M)
F T TO (0500 (D) T T)
For T _A = +70 to +85°C (Package Type M)
For I _A = +70 to +85°C (Package Type M)
OPERATING-TEMPERATURE RANGE (T _A): CD54 55 to +125°C CD74 40 to +85°C
OPERATING-TEMPERATURE RANGE (T _A): CD5455 to +125°C
$\begin{array}{lll} \text{OPERATING-TEMPERATURE RANGE (T_{A}): CD54} &55 \text{ to } +125^{\circ}\text{C} \\ & \text{CD74} &40 \text{ to } +85^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (T_{\text{Stg}})} &65 \text{ to } +150^{\circ}\text{C} \\ \end{array}$
$\begin{array}{lll} \text{OPERATING-TEMPERATURE RANGE (T_A): CD54} &55 \text{ to } +125^{\circ}\text{C} \\ & \text{CD74} &40 \text{ to } +85^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (Tstg)} &65 \text{ to } +150^{\circ}\text{C} \\ \text{LEAD TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} &65 \text{ to } +100^{\circ}\text{C} \\ \text{STORAGE TEMPERATURE (DURING SOLDERING):} $

RECOMMENDED OPERATING CONDITIONS:

For maximum reliability, normal operating conditions should be selected so that operation is always within the following ranges:

CHARACTERISTIC			LIMITS		
CHARACTERISTIC	MIN.	MAX.	UNITS		
Supply-Voltage Range, V _{CC} *:					
(For T _A = Full Package-Temperature Range)					
AC Types	1.5	5.5	V		
ACT Types	4.5	5.5	V		
DC Input or Output Voltage, V _I , V _O		0	VCC	٧	
Operating Temperature, T _A	CD54	-55	+125	°C	
	CD74	-40	+85	C	
Input Rise and Fall Slew Rate, dt/dv					
at 1.5 V to 3 V (AC Types)		0	50	ns/V	
at 3.6 v to 5.5 V (AC Types)		0	20	ns/V	
at 4.5 V to 5.5 V (ACT Types)		0	10	ns/V	

^{*} Unless otherwise specified, all voltages are referenced to ground.







CD54/74AC, ACT240 TYPES TERMINAL ASSIGNMENT

CD54/74AC, ACT241 TYPES TERMINAL ASSIGNMENT CD54/74AC, ACT244 TYPES TERMINAL ASSIGNMENT

STATIC ELECTRICAL CHARACTERISTICS: AC Series

					AMBIENT TEMPERATURE (T _A) - °C											
CHARACTERISTI	CS	TEST CO	NDITIONS	V _{cc}	+:	25	40 t	o +85	-55 to	+125	UNITS					
		V, (V)	l _o (mA)	(V)	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.						
High-Level Input				1.5	1.2		1.2		1.2							
Voltage	VIH			3	2.1		2.1		2.1	—	v					
				5.5	3.85	<u> </u>	3.85		3.85							
Low-Level Input				1.5	_	0.3	—	0.3		0.3						
Voltage	VIL			3		0.9	_	0.9		0.9	V					
				5.5	_	1.65	_	1.65	_	1.65	<u> </u>					
High-Level Output	,		-0.05	1.5	1.4		1.4	_	1.4							
Voltage	V _{OH}	ViH	-0.05	3	2.9		2.9	_	2.9							
		or	-0.05	4.5	4.4		4.4	_	4.4	_]					
		V _{IL}	-4	3	2.58	_	2.48		2.4		V					
			-24	4.5	3.94	· ·	3.8	_	3.7	_						
		#, * {	-75	5.5	-		3.85		_	<u> </u>						
		"'	-50	5.5		_	_		3.85]					
Low-Level Output			0.05	1.5	_	0.1	_	0.1	_	0.1						
Voltage	VOL	V _{IH}	0.05	3		0.1	_	0.1	_	0.1						
		or	0.05	4.5		0.1		0.1	_	0.1						
		VIL	12	3	_	0.36	_	0.44	_	0.5] v					
								24	4.5	_	0.36	_	0.44	_	0.5	
		#, * {	75	5.5	_			1.65	_	-						
		"· ~ {	50	5.5			_	_	· · -	1.65	1					
Input Leakage Current	l _t	V _{CC} or GND		5.5	_	±0.1	<u>-</u>	±1	_	±1	μΑ					
3-State Leakage Current	loz	V _{IH}														
		V _{IL} V _O = V _{CC}		5.5		±0.5	-	±5		±10	μΑ					
		or GND														
Quiescent Supply Current, MSI	loc	V _∞ or GND	0	5.5	_	8		80	-	160	μΑ					

[#]Test one output at a time for a 1-second maximum duration. Measurement is made by forcing current and measuring voltage to minimize power dissipation.

^{*}Test verifies a minimum 50-ohm transmission-line-drive capability at +85°C, 75 ohms at +125°C.

STATIC ELECTRICAL CHARACTERISTICS: ACT Series

		. ,		AMBIENT TEMPERATURE (TA) - °C							
CHARACTERISTI	cs	TEST CO	NDITIONS	V _{cc}	+	25	-40 t	o +85	-55 to	+125	UNITS
		V, (V)	l _o (mA)	(V)	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
High-Level Input Voltage	V _{IH}			4.5 to 5.5	2	_	2		2	_	V
Low-Level Input Voltage	VıL			4.5 to 5.5	_	0.8		0.8		0.8	V
High-Level Output		V _{IH} or	-0.05	4.5	4.4		4.4	-	4.4		
Voltage	V _{OH}	V _{IL}	-24	4.5	3.94		3.8	_	3.7		V
		#, * {	-75	5.5			3.85				
			-50	5.5				_	3.85		<u> </u>
Low-Level Output		ViH	0.05	4.5		0.1		0.1		0.1	
Voltage	V_{OL}	or V _{IL} #, * {	24	4.5		0.36		0.44		0.5	v
_			75	5.5				1.65			
		, l	50	5.5						1.65	
Input Leakage Current	t _i	V _{CC} or GND		5.5		±0.1	<u> </u>	±1	_	±1	μА
3-State Leakage Current	loz	V _{IH} or V _{IL} V _O =		5.5	_	±0.5		±5		±10	μΑ
	·	V _{cc} or GND									
Quiescent Supply Current, MSI	lcc	V _∞ or GND	0	5.5		8		80	_	160	μΑ
Additional Quiescent S Current per Input Pir TTL Inputs High 1 Unit Load		V _{cc} -2.1	·	4.5 to 5.5	_	2.4		2.8	_	3	mA

[#]Test one output at a time for a 1-second maximum duration. Measurement is made by forcing current and measuring voltage to minimize power dissipation.

* Test verifies a minimum 50-ohm transmission-line-drive capability at +85°C, 75 ohms at +125°C.

ACT INPUT LOADING TABLES

CD54/74ACT240					
INPUT UNIT LOADS*					
nA0 - A3	1.42				
10E	0.83				
20E	0.83				

CD54/74ACT241						
INPUT UNIT LOADS						
nA0 - A3	0.5					
10E	0.83					
20E	1.67					

CD54/74ACT244							
INPUT	INPUT UNIT LOADS*						
nA0 - A3	0.5						
10E	0.83						
20E	0.83						

^{*}Unit load is ∆I_∞ limit specified in Static Characteristics Chart, e.g., 2.4 mA max. @ 25°C.

SWITCHING CHARACTERISTICS: AC Series; $t_{\rm r}$ $t_{\rm r}$ = 3 ns, $C_{\rm L}$ = 50 pF

			AMBII	T .			
CHARACTERISTICS	SYMBOL	V _{cc}		o +85	-55 to +125		UNITS
	'	(V)	MIN.	MAX.	MIN.	MAX.]
Propagation Delays: Data to Outputs AC240	t _{PLH}	1.5 :3.3* 5†	2.6 1.9	82 9.2 6.5	 2.5 1.8	90 10.1 7.2	ns
AC241, 244	: tегн tенс	1.5 3.3 5		93 10.5 7.5	_ 2.9 2.1	103 11.5 8.2	ns
Output Enable Times	t _{PZL}	1.5 3.3 5	 4.6 3.1	136 16.4 10.9	_ 4.5 3	150 18 12	ns
Output Disable Times	t _{PLZ} t _{PHZ}	1.5 3.3 5	3.9 3.1	136 13.6 10.9	 3.8 3	150 15 12	ns
Power Dissipation Capacitance AC240 AC241, 244	C _{PD} §		65 Typ. 65 Typ. 71 Typ. 71 Typ.		pF		
Min. (Valley) V _{OH} During Switching of Other Outputs (Output Under Test Not Switching)	V _{онv} See Fig. 1	5	4 Typ. @ 25°C			V	
Max. (Peak) V _{OL} During Switching of Other Outputs (Output Under Test Not Switching)	V _{OLP} See Fig. 1	5	1 Тур. @ 25°С			V	
Input Capacitance	Cı	_		10	_	10	pF
3-State Output Capacitance	Co			15		15	pF

SWITCHING CHARACTERISTICS: ACT Series; t,, t, = 3 ns, C, = 50 pF

			AMBI	(A) - °C				
CHARACTERISTICS	SYMBOL	V _{cc} (V)	-40	-40 to +85		+125	UNITS	
	}		MIN.	MAX.	MIN.	MAX.		
Propagation Delays: Data to Outputs ACT240	t _{PLH} t _{PHL}	5†	2.3	7.8	2.2	8.6	ns	
ACT241, 244	t _{PLH} t _{PHL}	5	2.5	8.7	2.4	9.6	ns	
Output Enable Times	t _{PZL}	5	3.5	12.2	3.4	13.4	ns	
Output Disable Times	t _{PLZ}	5	3.5	12.2	3.4	13.4	ns	
Power Dissipation Capacitance ACT240 ACT241, 244	C _{PO} §		65 Typ. 65 Typ. 71 Typ. 71 Typ.			pF		
Min. (Valley) V _{он} During Switching of Other Outputs (Output Under Test Not Switching)	V _{онv} See Fig. 1	5	4 Typ. @ 25°C		V			
Max. (Peak) Vol. During Switching of Other Outputs (Output Under Test Not Switching)	V _{OLP} See Fig. 1	5	1 Typ. @ 25°C		v			
Input Capacitance	Cı		_	10	_	10	pF	
3-State Output Capacitance	Co		_	15	_	15	ρF	

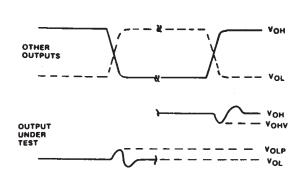
^{*3.3} V: min. is @ 3.6 V max. is @ 3 V

 $\ddagger C_{PD}$ is used to determine the dynamic power consumption, per package. For AC series: $P_D = V_{CC}^2 \, f_i \, (C_{PD} + C_L)$ For ACT series: $P_D = V_{CC}^2 \, f_i \, (C_{PD} + C_L) + V_{CC} \, \Delta I_{CC}$ where f_i = input frequency

†5 V: min. is @ 5.5 V max. is @ 4.5 V C_L = output load capacitance

 $V_{CC} = supply voltage$

PARAMETER MEASUREMENT INFORMATION



NOTES:

- VOHY AND VOLP ARE MEASURED WITH RESPECT TO A GROUND REFERENCE NEAR THE OUTPUT UNDER TEST.
 INPUT PULSES HAVE THE FOLLOWING CHARACTERISTICS:
- PRR ≤ 1 MHz, t₁ = 3 ns, t₁ = 3 ns, 5 KEW 1 ns.

 R.F. FIXTURE WITH 700-MHz DESIGN RULES REQUIRED.
 IC SHOULD BE SOLDERED INTO TEST BOARD AND BYPASSED WITH 0.1 F CAPACITOR. SCOPE AND PROBES REQUIRE 700-MHz BANDWIDTH.

9205-42406

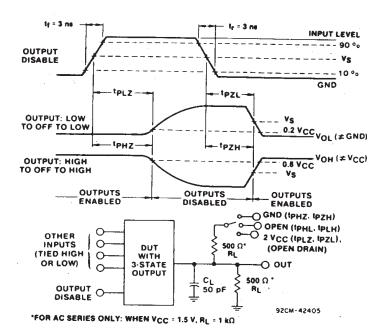
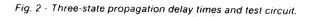
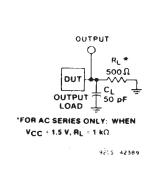
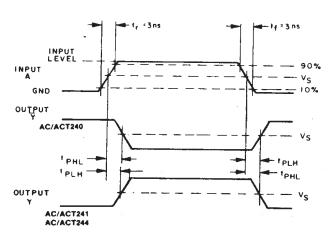


Fig. 1 - Simultaneous switching transient waveforms.







9205-42407

Fig. 3 - Propagation delay times and test circuit.

	CD54/74AC	CD54/74ACT
Input Level	V _{cc}	3 V
Input Switching Voltage, Vs	0.5 V _{cc}	1.5 V
Output Switching Voltage, Vs	0.5 V _{cc}	0.5 V _{CC}





24-Aug-2014

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
CD54AC240F3A	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	CD54AC240F3A	Sample
CD54AC244F3A	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	CD54AC244F3A	Sample
CD54ACT240F3A	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	CD54ACT240F3A	Samples
CD54ACT241F3A	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	CD54ACT241F3A	Samples
CD54ACT244F3A	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	CD54ACT244F3A	Samples
CD74AC240E	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74AC240E	Samples
CD74AC240EE4	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74AC240E	Samples
CD74AC240M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC240M	Samples
CD74AC240M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC240M	Samples
CD74AC244E	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74AC244E	Samples
CD74AC244EE4	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type -55 to 125		CD74AC244E	Samples
CD74AC244M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC244M	Samples
CD74AC244M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC244M	Samples
CD74AC244M96G4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC244M	Samples
CD74ACT240E	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74ACT240E	Samples
CD74ACT240EE4	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74ACT240E	Samples
CD74ACT240M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT240M	Samples
CD74ACT240M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT240M	Samples



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PACKAGE OPTION ADDENDUM

24-Aug-2014

Orderable Device	Status	Package Type	_	Pins	_	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
CD74ACT240M96E4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT240M	Samples
CD74ACT241E	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74ACT241E	Samples
CD74ACT241M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT241M	Samples
CD74ACT244E	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74ACT244E	Samples
CD74ACT244M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT244M	Samples
CD74ACT244M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT244M	Samples
CD74ACT244M96E4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT244M	Samples
CD74ACT244M96G4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT244M	Samples
CD74ACT244MG4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT244M	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

⁽³⁾ MSL. Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.



PACKAGE OPTION ADDENDUM

24-Aug-2014

- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF CD54AC240, CD54AC244, CD54ACT240, CD54ACT241, CD54ACT244, CD74AC240, CD74AC244, CD74ACT240, CD74ACT241, CD74ACT244:

- Catalog: CD74AC240, CD74AC244, CD74ACT240, CD74ACT241, CD74ACT244
- Military: CD54AC240, CD54AC244, CD54ACT240, CD54ACT241, CD54ACT244

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

PACKAGE MATERIALS INFORMATION

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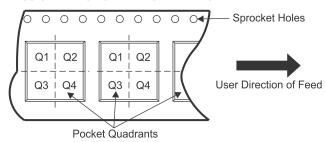
TAPE AND REEL INFORMATION





A0	
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	_	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74AC240M96	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
CD74AC244M96	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
CD74ACT240M96	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
CD74ACT241M96	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
CD74ACT244M96	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1

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*All dimensions are nominal

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Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74AC240M96	SOIC	DW	20	2000	367.0	367.0	45.0
CD74AC244M96	SOIC	DW	20	2000	367.0	367.0	45.0
CD74ACT240M96	SOIC	DW	20	2000	367.0	367.0	45.0
CD74ACT241M96	SOIC	DW	20	2000	367.0	367.0	45.0
CD74ACT244M96	SOIC	DW	20	2000	367.0	367.0	45.0

14 LEADS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.





SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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